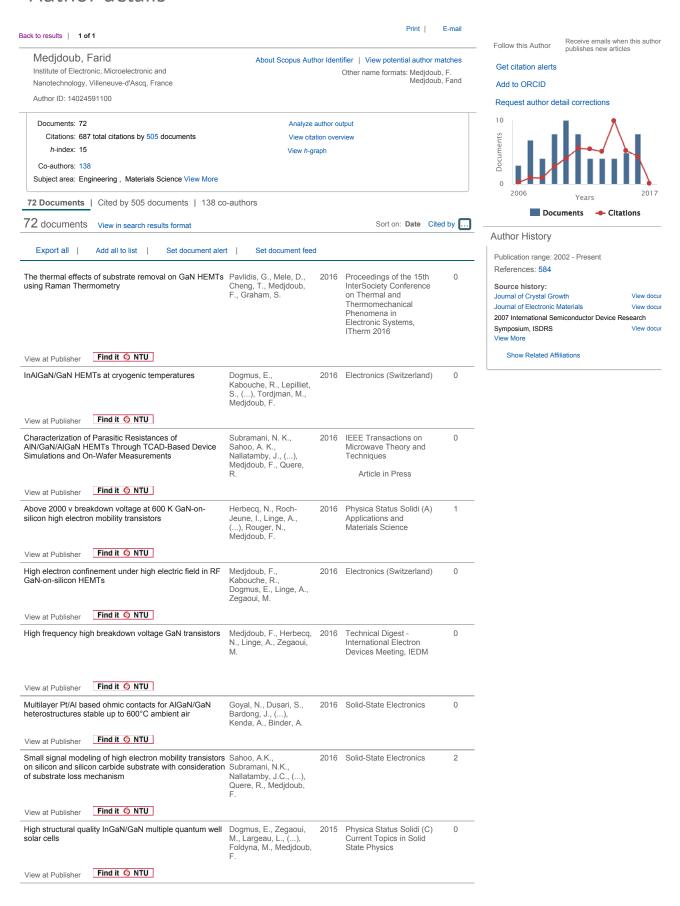
Scopus Search Sources Alerts Lists Help Register Login

Author details



Back to results | 1 of 1

Temperature depende resistance extraction o	nt contact and channel sheet of GaN HEMT	Sahoo, A.K., Subramani, N.K., Nallatamby, J.C., (), Quere, R., Medjdoub, F.	2015	International Workshop on Integrated Nonlinear Microwave and Millimetre-wave Circuits, INMMiC 2015	0
View at Publisher F	ind it 🥱 NTU				
High PAE high reliabili	ty AIN/GaN double heterostructure	Medjdoub, F., Zegaoui, M., Linge, A., (), Meneghesso, G., Zanoni, E.	2015	Solid-State Electronics	0
View at Publisher F	ind it 6 NTU				
GaN-on-silicon high el blocking voltage of 3 k	ectron mobility transistors with V	Herbecq, N., Roch- Jeune, I., Linge, A., (), Zegaoui, M., Medjdoub, F.	2015	Electronics Letters	4
View at Publisher F	ind it 6 NTU				
	in high-polarization sub-10nm BaN/GaN heterostructure	Medjdoub, F., Kabouche, R., Linge, A., (), Tordjman, M., Di Forte-Poisson, MA.	2015	Applied Physics Express	2
View at Publisher F	ind it 6 NTU				
Towards millimeter-wa ultrathin Al-rich barrier	ive high PAE high power using GaN devices	Medjdoub, F., Okada, E., Grimbert, B., (), Ducatteau, D., Rolland, N.	2014	2014 Asia-Pacific Microwave Conference Proceedings, APMC 2014	0
Find it 6 NTU					
Ultrathin barrier GaN-c wave applications	on-Silicon devices for millimeter	Medjdoub, F.	2014	Microelectronics Reliability	1
View at Publisher F	ind it 6 NTU				
High performance high	n reliability AIN/GaN DHFET	Medjdoub, F., Okada, E., Grimbert, B., (), Zanoni, E., Meneghesso, G.	2014	European Solid-State Device Research Conference	1
View at Publisher F	ind it 6 NTU				
1900V, 1.6mωcm ² AIN realized by local subst	l/GaN-on-Si power devices rate removal	Herbecq, N., Roch- Jeune, I., Rolland, N., (), Germain, M., Medjdoub, F.	2014	Applied Physics Express	15
View at Publisher F	ind it 6 NTU				
	tration of sub-200-nm AIN/GaN- rostructure HEMTs for Ka-band	Meneghesso, G., Meneghini, M., Medjdoub, F., (), Silvestri, R., Zanoni, E.	2013	IEEE Transactions on Device and Materials Reliability	6
View at Publisher	ind it 🥱 NTU				
	e / high power AIN/GaN-on-silicon HEMTs operating at 40 GHz	Medjdoub, F., Tagro, Y., Grimbert, B., (), Zanoni, E., Meneghesso, G.	2013	IEEE International Reliability Physics Symposium Proceedings	1
View at Publisher F	ind it 💪 NTU				
Toward highly scaled Amillimeter wave application	AIN/GaN-on-Silicon devices for ations	Medjdoub, F., Tagro, Y., Grimbert, B., Ducatteau, D., Rolland, N.	2013	International Journal of Microwave and Wireless Technologies	1
View at Publisher F	ind it 🥱 NTU				
Display 20 ▼ resu	ilts per page			Page 1	T

The data displayed above is compiled exclusively from articles published in the Scopus database. To request corrections to any inaccuracies or provide any further feedback, please contact us (registration required). The data displayed above is subject to the privacy conditions contained in the privacy policy.

Privacy matters

ELSEVIER

Terms and conditions Privacy policy

Copyright © 2016 Elsevier B.V. All rights reserved. Scopus® is a registered trademark of Elsevier B.V. Cookies are set by this site. To decline them or learn more, visit our Cookies page.

RELX Grou